

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/700,487	HITACHI ET AL.	
Examiner Suman Debnath		Art Unit 2135	Page 1 of 1	

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,434,991	07-1995	Maeda et al.	711/112
*	B	US-2002/0129254 A1	09-2002	Kuroda, Kazuo	713/176
*	C	US-6,639,878 B1	10-2003	Gabryjelski, Henry P.	369/30.25
*	D	US-2002/0076204 A1	06-2002	Nakano et al.	386/94
*	E	US-2003/0169878 A1	09-2003	Miles, Anthony	380/201
*	F	US-6,880,081 B1	04-2005	Itkis, Yevgeny Yakov (Gene)	713/163
*	G	US-6,859,535 B1	02-2005	Tatebayashi et al.	380/201
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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